

HIGH VOLTAGE FAST SWITCHING NPN POWER TRANSISTOR

PRELIMINARY DATA

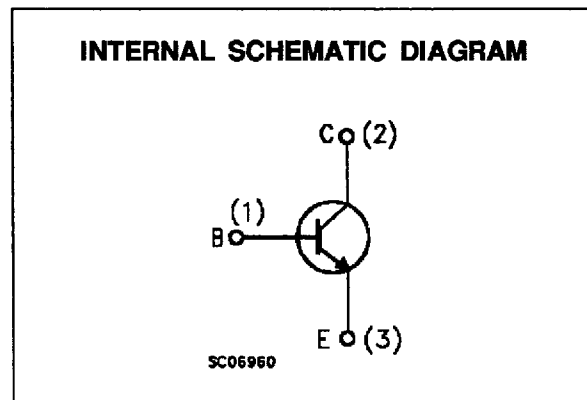
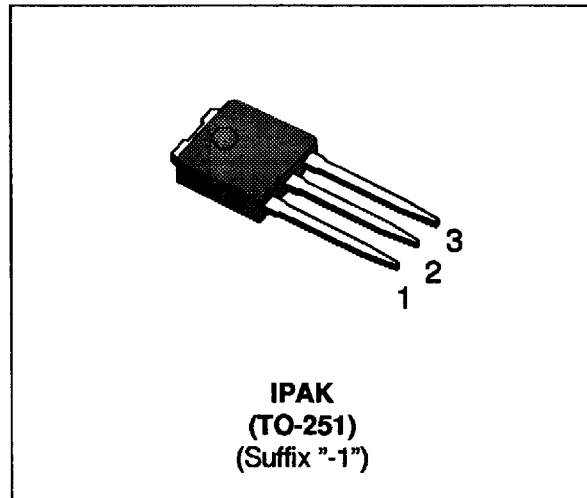
- SGS-THOMSON PREFERRED SALESTYPE
- HIGH VOLTAGE CAPABILITY
- LOW SPREAD OF DYNAMIC PARAMETERS
- MINIMUM LOT-TO-LOT SPREAD FOR RELIABLE OPERATION
- VERY HIGH SWITCHING SPEED
- FULLY CHARACTERISED AT 125°C
- THROUGH-HOLE IPAK (TO-251) POWER PACKAGE IN TUBE (SUFFIX "-1")
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APPLICATIONS

- ELECTRONIC BALLASTS FOR FLUORESCENT LIGHTING
- FLYBACK AND FORWARD SINGLE TRANSISTOR LOW POWER CONVERTERS

DESCRIPTION

The BULD138 is manufactured using high voltage Multi Epitaxial Planar technology for high switching speeds and high voltage capability. It uses a Cellular Emitter structure with planar edge termination to enhance switching speeds. The BUL series is designed for use in lighting applications and low cost switch-mode power supplies.



ABSOLUTE MAXIMUM RATINGS

Symbol	Parameter	Value	Unit
V _{CES}	Collector-Emitter Voltage (V _{BE} = 0)	800	V
V _{CEO}	Collector-Emitter Voltage (I _B = 0)	400	V
V _{EBO}	Emitter-Base Voltage (I _C = 0)	9	V
I _C	Collector Current	5	A
I _{CM}	Collector Peak Current (t _p < 5 ms)	8	A
I _B	Base Current	2	A
I _{BM}	Base Peak Current (t _p < 5 ms)	4	A
P _{tot}	Total Dissipation at T _c = 25 °C	30	W
T _{stg}	Storage Temperature	-65 to 150	°C
T _j	Max. Operating Junction Temperature	150	°C

BULD138

THERMAL DATA

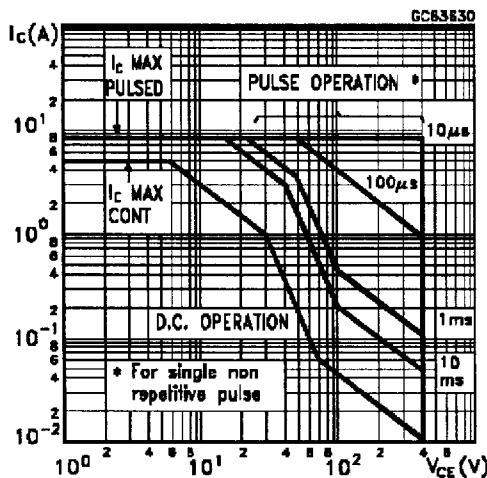
$R_{thj-case}$	Thermal Resistance Junction-case	Max	4.16	$^{\circ}C/W$
$R_{thj-amb}$	Thermal Resistance Junction-ambient	Max	100	$^{\circ}C/W$

ELECTRICAL CHARACTERISTICS ($T_{case} = 25^{\circ}C$ unless otherwise specified)

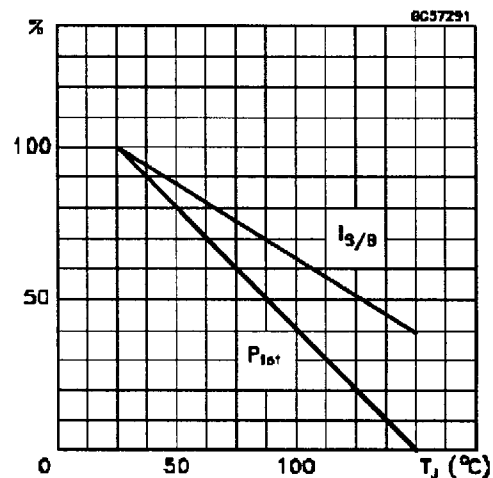
Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit
I_{CES}	Collector Cut-off Current ($V_{BE} = 0$)	$V_{CE} = 800 V$			100	μA
		$V_{CE} = 800 V \quad T_j = 125^{\circ}C$			500	μA
I_{CEO}	Collector Cut-off Current ($I_B = 0$)	$V_{CE} = 400 V$			250	μA
$V_{CEO(sus)}$	Collector-Emitter Sustaining Voltage	$I_C = 100 mA \quad L = 25 mH$	400			V
V_{EBO}	Emitter-Base Voltage	$I_E = 10 mA$	9			V
$V_{CE(sat)^*}$	Collector-Emitter Saturation Voltage	$I_C = 1 A \quad I_B = 0.2 A$			0.5	V
		$I_C = 2 A \quad I_B = 0.4 A$			0.7	V
		$I_C = 3 A \quad I_B = 0.6 A$			1	V
$V_{BE(sat)^*}$	Base-Emitter Saturation Voltage	$I_C = 1 A \quad I_B = 0.2 A$			1.1	V
		$I_C = 2 A \quad I_B = 0.4 A$			1.3	V
		$I_C = 3 A \quad I_B = 0.6 A$			1.5	V
h_{FE}^*	DC Current Gain	$I_C = 2 A \quad V_{CE} = 5 V$	8			
		$I_C = 10 mA \quad V_{CE} = 5 V$	10			
t_s t_f	INDUCTIVE LOAD Storage Time Fall Time	$I_C = 2 A \quad I_{B1} = 0.4 A$ $V_{BE(off)} = -5 V \quad R_{BB} = 0 \Omega$ $V_{CL} = 250 V \quad L = 200 \mu H$		0.7	1.4	μs ns
				50	100	
t_s t_f	INDUCTIVE LOAD Storage Time Fall Time	$I_C = 2 A \quad I_{B1} = 0.4 A$ $V_{BE(off)} = -5V \quad R_{BB} = 0 \Omega$ $V_{CL} = 250 V \quad L = 200 \mu H$ $T_j = 125^{\circ}C$		1		μs ns
				75		

* Pulsed: Pulse duration = 300 μs , duty cycle 1.5 %

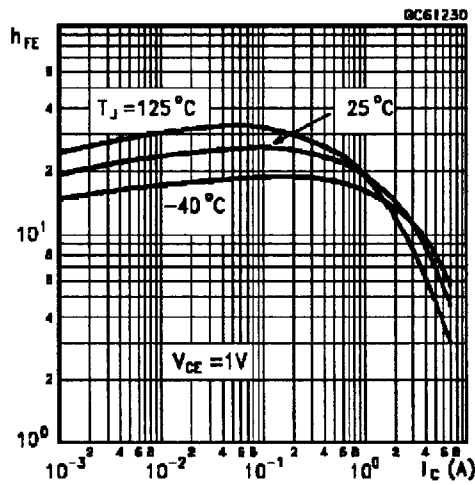
Safe Operating Areas



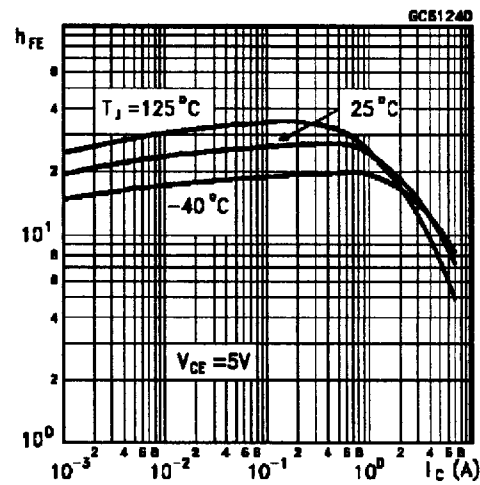
Derating Curves



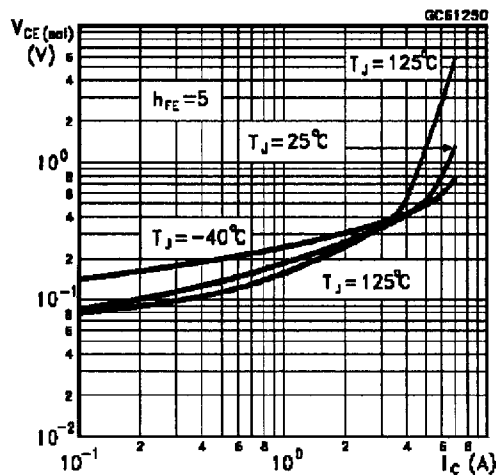
DC Current Gain



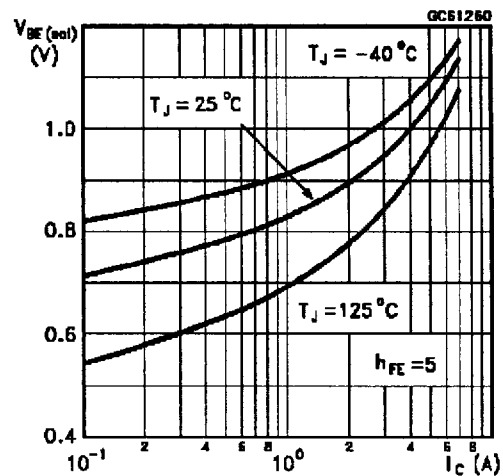
DC Current Gain



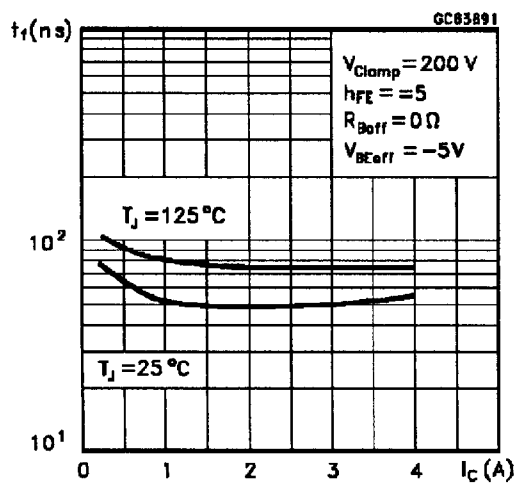
Collector-Emitter Saturation Voltage



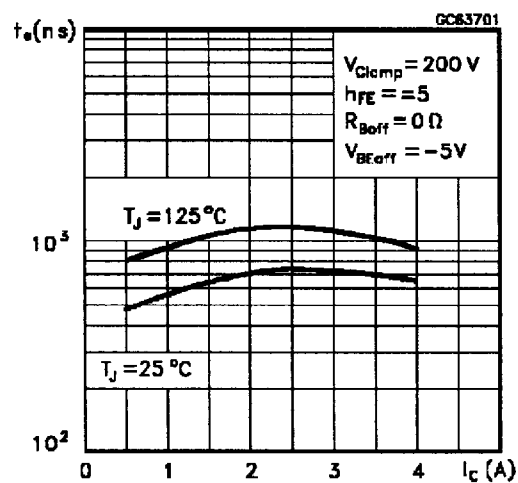
Base-Emitter Saturation Voltage



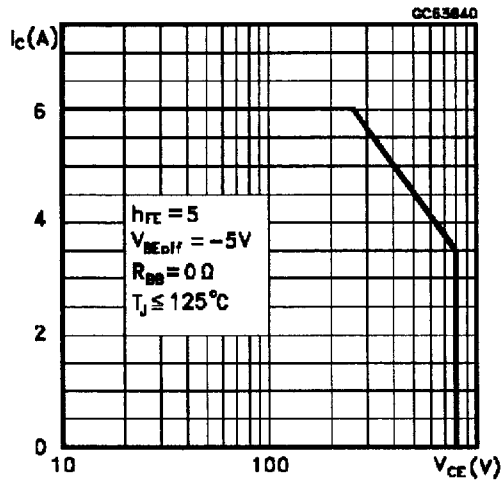
Inductive Fall Time



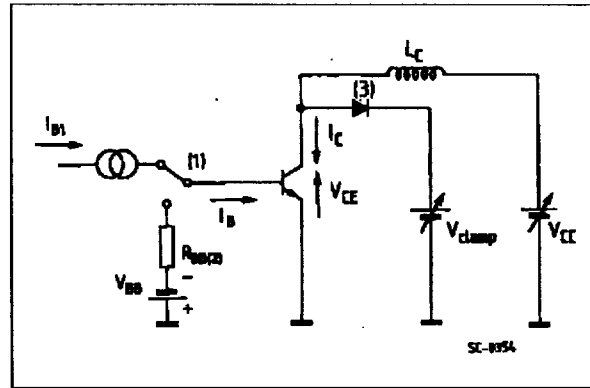
Inductive Storage Time



Reverse Biased SOA



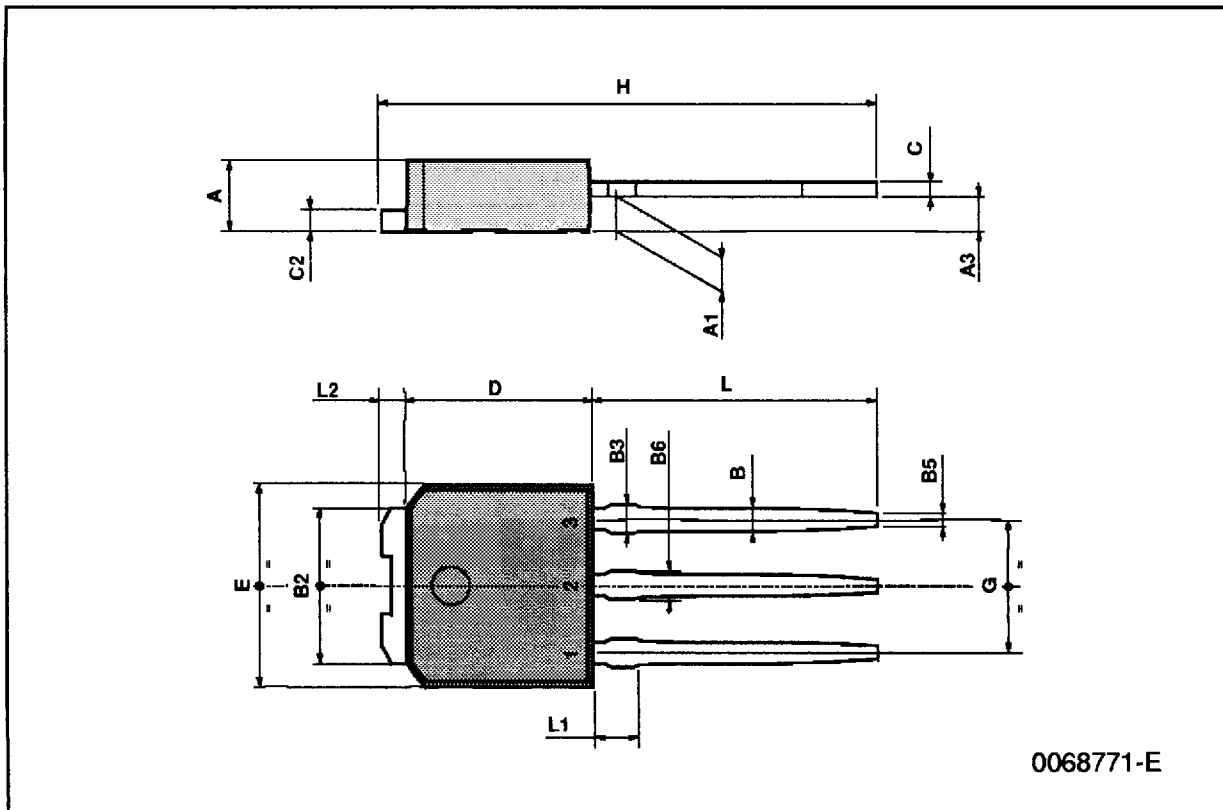
RBSOA and Inductive Load Switching Test Circuit



- (1) Fast electronic switch
- (2) Non-inductive Resistor
- (3) Fast recovery rectifier

TO-251 (IPAK) MECHANICAL DATA

DIM.	mm			Inch		
	MIN.	TYP.	MAX.	MIN.	TYP.	MAX.
A	2.2		2.4	0.086		0.094
A1	0.9		1.1	0.035		0.043
A3	0.7		1.3	0.027		0.051
B	0.64		0.9	0.025		0.031
B2	5.2		5.4	0.204		0.212
B3			0.85			0.033
B5		0.3			0.012	
B6			0.95			0.037
C	0.45		0.6	0.017		0.023
C2	0.48		0.6	0.019		0.023
D	6		6.2	0.236		0.244
E	6.4		6.6	0.252		0.260
G	4.4		4.6	0.173		0.181
H	15.9		16.3	0.626		0.641
L	9		9.4	0.354		0.370
L1	0.8		1.2	0.031		0.047
L2		0.8	1		0.031	0.039



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